

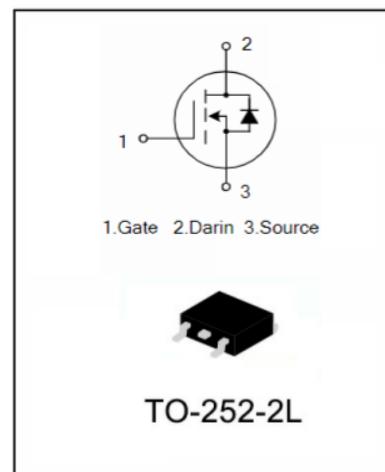
## 80A, 30V N-CHANNEL MOSFET

### GENERAL DESCRIPTION

The SFD3008T uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

### FEATURES

- ◆ 80A,30V, $R_{DS(on)(typ.)}=4.8m\Omega @ V_{GS}=10V$
- ◆ Excellent package for good heat dissipation
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high EAS
- ◆ High density cell design for ultra low Rdson
- ◆ Special process technology for high ESD capability
- ◆ Exceptional on-resistance and maximum DC current capability



### ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFD3008T	TO-252-2L	SFD3008T	Pb free	Reel

### ABSOLUTE MAXIMUM RATINGS ( $T_c = 25^\circ C$ unless otherwise noted)

Characteristics		Symbol	Ratings	Unit
Drain-Source Voltage		$V_{DS}$	30	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	V
Drain Current	$T_c = 25^\circ C$	$I_D$	80	A
	$T_c = 70^\circ C$		46	
Drain Current Pulsed (Note 1)		$I_{DM}$	280	A
Single Pulsed Avalanche Energy (Note 2)		$E_{AS}$	56	mJ
Maximum Power Dissipation		$P_D$	46	W
Operation Junction Temperature Range		$T_J$	-55~+150	°C
Storage Temperature Range		$T_{stg}$	-55~+150	°C

### Thermal Characteristics

Symbol	Parameter	Value	Unit
$R_{aJC}$	Thermal Resistance, Junction-to-Case	2.52	°C/W

**Electrical Characteristics ( $T_J = 25^\circ\text{C}$  unless otherwise noted)**

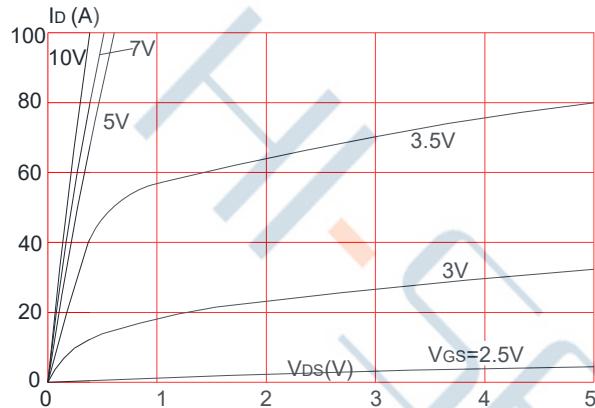
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu\text{A}$ ,	30	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1.0	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current, Forward	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.0	1.5	2.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance (Note 3)	$V_{GS} = 10V, I_D = 30A$	-	4.8	6	$\text{m}\Omega$
$R_{DS(on)}$		$V_{GS} = 4.5V, I_D = 20A$	-	7.5	12	$\text{m}\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	-	1614	-	pF
$C_{oss}$	Output Capacitance		-	245	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	215	-	pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS} = 15V, I_D = 30A, V_{GS} = 10V, R_{GEN} = 3.0\Omega$	-	7.5	-	ns
$t_r$	Turn-On Rise Time		-	14.5	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	35.2	-	ns
$t_f$	Turn-Off Fall Time		-	9.6	-	ns
$Q_g$	Total Gate Charge	$V_{DS} = 15V, I_D = 30A, V_{GS} = 10V$	-	33.7	-	nC
$Q_{gs}$	Gate-Source Charge		-	8.5	-	nC
$Q_{gd}$	Gate-Drain Charge		-	7.5	-	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_s$	Maximum Continuous Drain-Source Diode Forward Current	-	-	80	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current			280	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_s = 30A$	-	-	1.2	V

**Notes:**

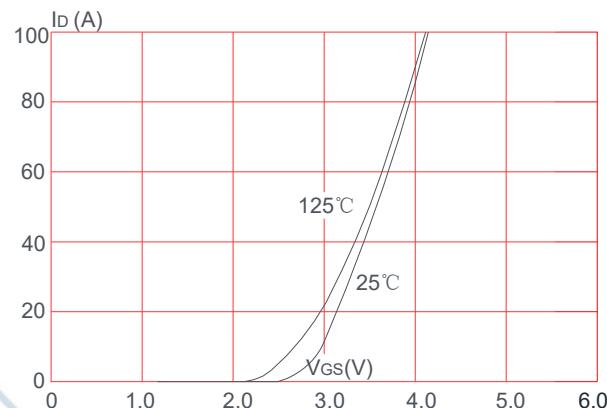
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition:  $T_J=25^\circ\text{C}, V_{DD}=15V, V_G=10V, R_G=25\Omega, L=0.5\text{mH}, I_{AS}=15A$
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$

## Typical Performance Characteristics

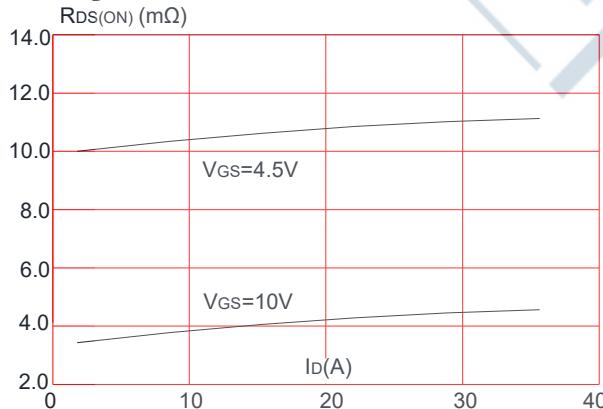
**Figure 1:** Output Characteristics



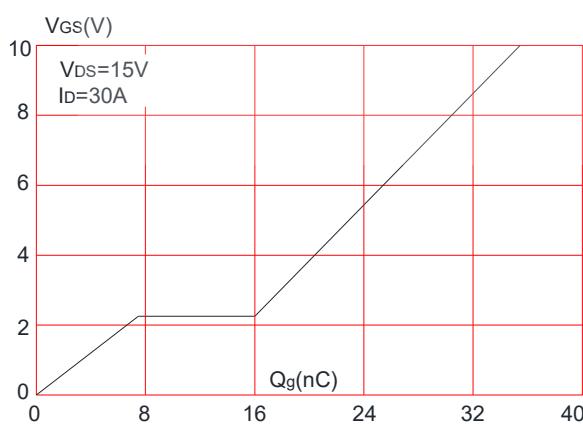
**Figure 2:** Typical Transfer Characteristics



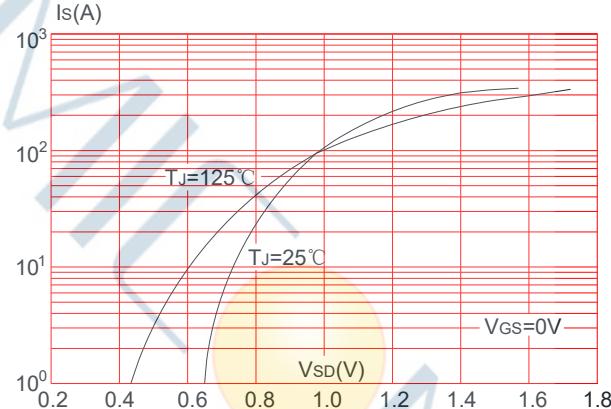
**Figure 3:** On-resistance vs. Drain Current



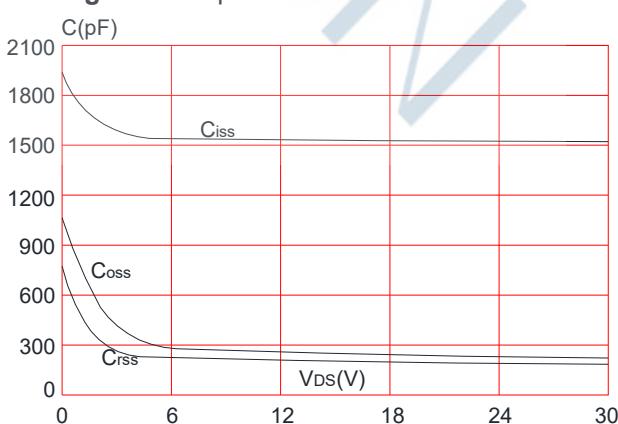
**Figure 5:** Gate Charge Characteristics



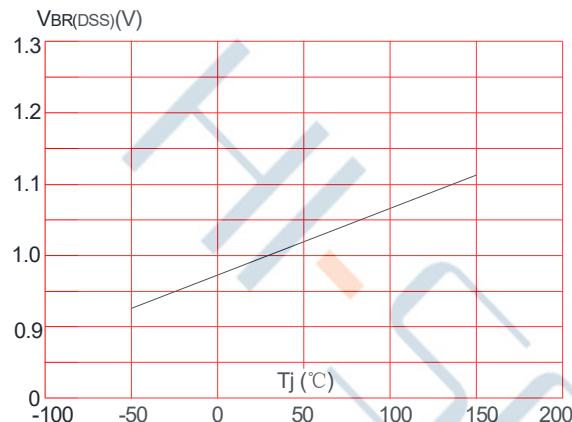
**Figure 4:** Body Diode Characteristics



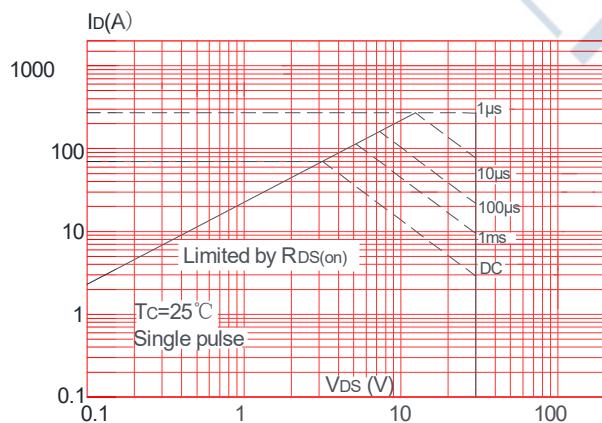
**Figure 6:** Capacitance Characteristics



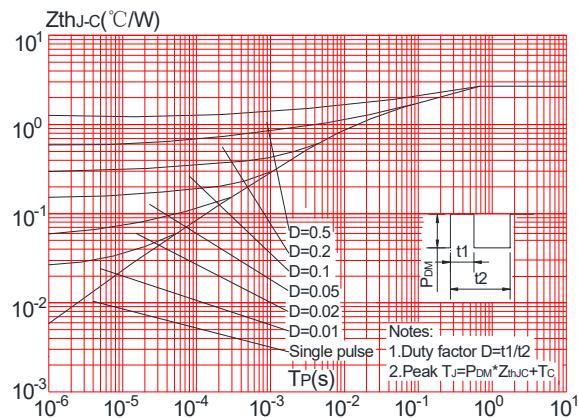
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



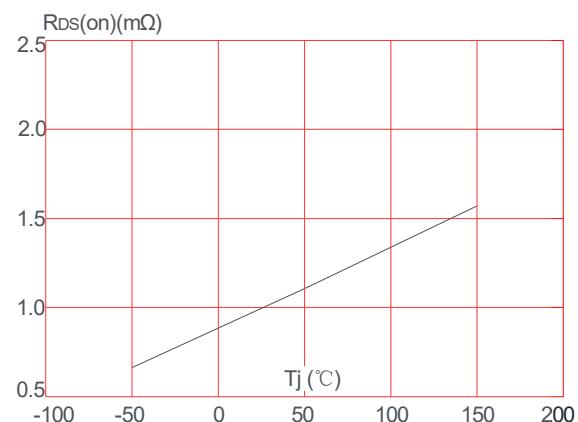
**Figure 9:** Maximum Safe Operating Area



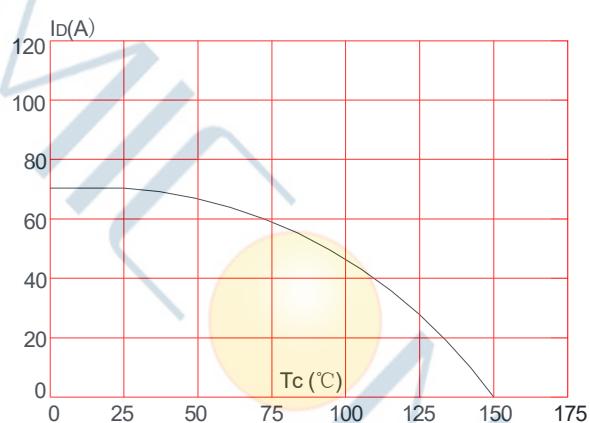
**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Case



**Figure 8:** Normalized on Resistance vs. Junction Temperature



**Figure 10:** Maximum Continuous Drain Current vs. Case Temperature



## Test Circuit

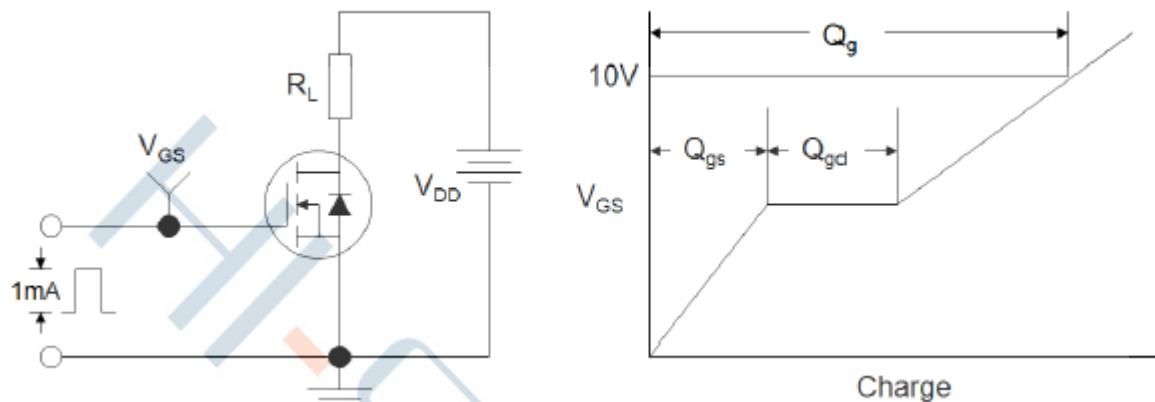


Figure1:Gate Charge Test Circuit & Waveform

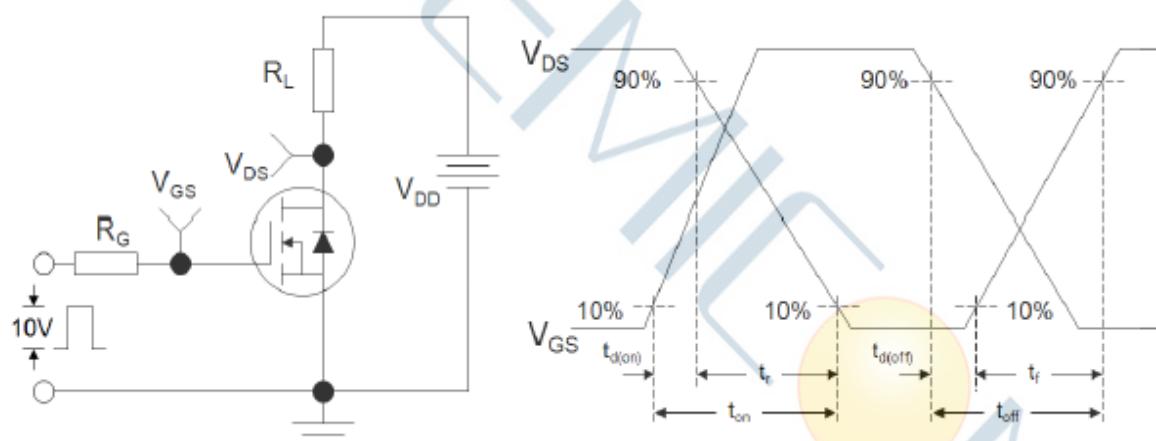


Figure 2: Resistive Switching Test Circuit & Waveforms

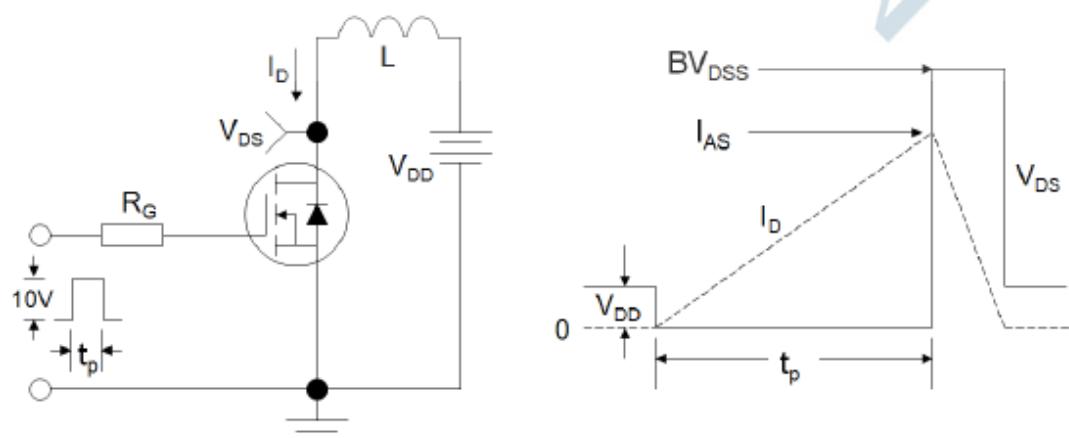
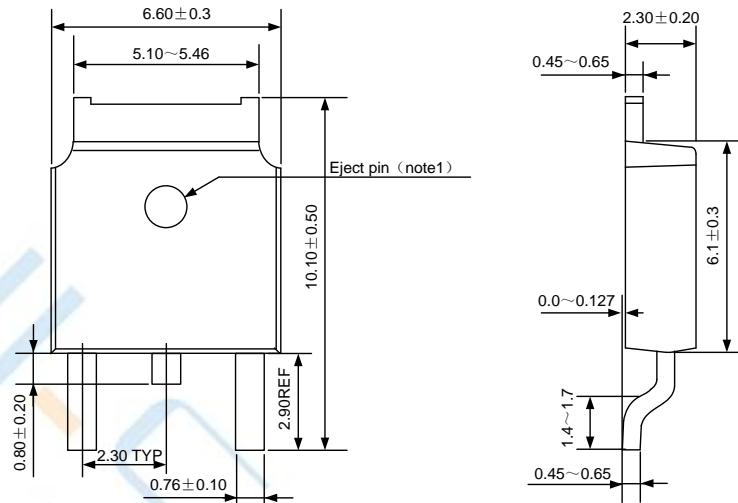


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms

## PACKAGE OUTLINE(continued)

TO-252-2L(1)

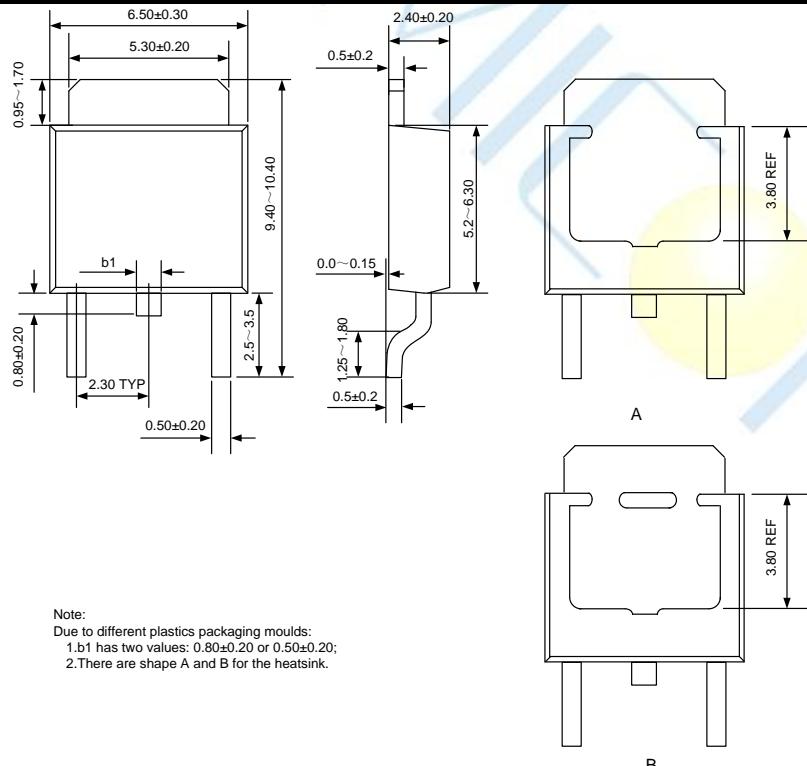
UNIT: mm



NOTE1 □ There are two conditions for this position: has an eject pin or has no eject pin.

TO-252-2L(2)

UNIT: mm



## Note:

- 1.b1 has two values:  $0.80 \pm 0.20$  or  $0.50 \pm 0.20$ ;
- 2.There are shape A and B for the heatsink.